

Notice of References Cited	Application/Control No. 10/555,286	Applicant(s)/Patent Under Reexamination JIMENEZ MAYORGA ET AL.	
	Examiner SUN JAE Y. LOEWE	Art Unit 1626	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Patani et al., Chem. Rev., 96, 3147-3176
	V	Fukui et al., caplus an 2002:142667
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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